HEER HOME I SEARCH HEER I SHOP I WEB ACCOUNT I CONTACT HEER



Membership Public	Welcome United States Patent and Trademark Office			
Help FAQ Terms IEE	E Peer Review Quick Links See			
Vectorie to 1999 Aplore - Honse - What Can 1 Access?	Your search matched 0 of 1138071 documents. A maximum of 500 results are displayed, 15 to a page, sorted by Relevance Descending order.			
O-Log-out	Refine This Search:			
Tables of Contents	You may refine your search by editing the current search expression or enterinew one in the text box.			
O- Journals & Magazines	algorithm 42 Search			
O- Conference Proceedings	Check to search within this result set			
O- Standards	Results Key:			
Search	JNL = Journal or Magazine CNF = Conference STD = Standard			
O- By Author O- Basic O- Advanced O- CrossRef	Results: No documents matched your query.			
sender sevic				
O- Join IEEE O- Establish IEEE Web Account				
O- Access the IEEE Member Digital Library				

Print Format

O- Access the

IEEE Enterprise File Cabinst

itame | Log.eut | Journals | Conference Proceedings | Standards | Search by Author | Basic Search | Advanced Search | Join IEEE | Web Account |
New this week | OPAC Linking Information | Your Feedback | Technical Support | Email Alerting | No Robots Please | Release Notes | IEEE Online
Publications | Help. | FAQ | Terms | Back to You

Copyright © 2004 IEEE — All rights reserved

B ACCOUNT | CONTACT IEEE



EEE HOME SEARC	HIEEE SHOP	I WES ACCOUNT	CONTACT IEEE
Membership Fubil	cations/Services	Standards Con	ferences Careers/Jobs
	XDO/E	\$5000000000000000000000000000000000000	Welcome States Patent and Traden
Help FAQ Terms II	EEE Peer Review	Quick Links	
Vescole to IRE volore O- Home O- What Can I Access?	Your search	n of 500 results	1138071 documents are displayed, 15 to

Walcoma United States Patent and Trademark Office



ched 1 of 1138071 documents. 00 results are displayed, 15 to a page, sorted by Relevance

Refine This Search: Pablics of Contents

Journals & Magazines

()- Log-out

-)- Conference **Proceedings**
- Standards

Search

- O- By Author O- Basic
- O- Advanced
- O- CrossRef

Member Services

- Or Join IEEE
- O- Establish IEEE Web Account
- Access the **IEEE Member** Digital Library

Access the MEEE Enterprise File Cablest

You may refine your search by editing the current search expression or enteri new one in the text box.

(a method for eliciting process models<in>ti)

Search

Check to search within this result set

Results Key:

JNL = Journal or Magazine CNF = Conference STD = Standard

1 Elicit: a method for eliciting process models

Madhavji, N.H.; Holtje, D.; Won Kook Hong; Bruckhaus, T.; Software Process, 1994. 'Applying the Software Process', Proceedings., Third International Conference on the , 10-11 Oct. 1994 Pages:111 - 122

[Abstract]

[PDF Full-Text (960 KB)] **IEEE CNF**

Print Format

Home | Log:out | Journals | Conference Proceedings | Standards | Search by Author | Basic Search | Advanced Search | Join IEEE | Web Account | New this week | OPAC Linking Information | Your Feedback | Technical Support | Email Alerting | No. Robots Please | Release Notes | IEEE Online Publications | Help. | FAQ | Terms | Sack to You

Copyright © 2004 IEEE - All rights reserved